Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/737,419	BURT ET AL.	
Examiner	Art Unit	•
Khanh V. Nguyen	2817	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
330/9,69,98,99,100,103,107,259,260, 280,284,291,292,307 + keywords	04/26/05 (06/25/06)	NKV		
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